

# Search Notes



Application/Control No.

10/708,850

Examiner

Jean W. Désir

Applicant(s)/Patent under  
Reexamination

SHAN ET AL.

Art Unit

2622

## SEARCHED

Class	Subclass	Date	Examiner
348	663	9/7/06	
	665		
	667		
	669		
	670		
	666		
	699		
	700, 701		
	908		
updated	3/21/07		
Search			

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
348	665	3/21/07	
	669		
	701		

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST	9/7/06	